NOTES:

- 1. SUBSTRATE FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL TO SURFACE S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE):

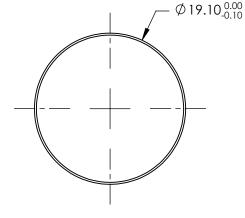
S1: 1064 HR Coating R (ABS) > 99.80% @ 1064nm @ 45° AOI R (AVG) > 99.5% @ 1046 - 1074nm @ 45° AOI

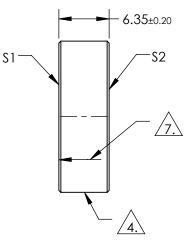
DAMAGE THRESHOLD, PULSED: 20 J/cm², 20ns, 20Hz @ 1064nm CW: 1MW/cm² @ 1064nm

S2: NONE

4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES
- APPLY ARROW ON EDGE WITH LASER ETCH, PENCIL, OR PERMANENT INK POINTING TOWARDS SURFACE \$1





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

				DIMENSIONS ARE FOR REFERENCE ONLY			
	S1	\$2]		@		
SHAPE	PLANO	PLANO			Edmund Optics	R	
SURFACE QUALITY	10-5	COMMERCIAL POLISH					
SURFACE FLATNESS	0.10 WAVE	N/A			Ø19.1mm x 6.35mm,1064nm, NdYAG MIRR	NOR	
MIN CLEAR APERTURE	Ø17.19	N/A	THIRD ANGLE	TITLE	45° AOI		
MIN COATING APERTURE	Ø17.19	N/A					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO		HEET OF 1	

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY